




FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	Atty. Docket No. 84885LMB Customer No. 01333	Serial No.
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee		
LIST OF ART CITED BY APPLICANT <i>(Use several sheets if necessary)</i>	Applicant: Peter T. Aylward, et al	
	Filing Date	Group

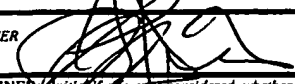
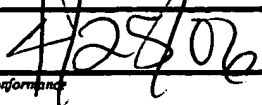
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Examiner <i>Initials</i>	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	3,299,192	01-17-1967	John H. Lux			
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Examiner <i>Initials</i>	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
A	1 285 741 A1	02-26-2003	EP				X
	0 838 321 B1	12-10-2003	EP				
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)	
	EP01890228.8 application, filed 7/2/2001, now publication EP1285741A1
	Japanese Abstract JP2839905B2 derived from JP3062028 A
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	Japanese Abstract JP08-132415
	Japanese Abstract JP09-106038
	Japanese Abstract JP09-127648
	Japanese Abstract JP10-249915
	Japanese Abstract JP11-023814
	Japanese Abstract JP3308733

EXAMINER 	DATE CONSIDERED 
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